PHK5NQ15T

N-channel TrenchMOS standard level FET

Rev. 02 — 4 March 2010

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

 Low conduction losses due to low on-state resistance

1.3 Applications

DC-to-DC convertors switching

General purpose switching

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	150	V		
I _D	drain current	T_{sp} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> and <u>3</u>	-	-	5	Α		
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 2</u>	-	-	6.25	W		
Dynamic	characteristics							
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V; } I_D = 5 \text{ A; } V_{DS} = 75 \text{ V;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 11}}{\text{ or } 100 \text{ C}}$	-	12	-	nC		
Static ch	Static characteristics							
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 5 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 9 and $\underline{10}$	-	56	75	mΩ		



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2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source	8月月月5	D
3	S	source		
4	G	gate		
5	D	drain	1	mbb076 S
6	D	drain	SOT96-1 (SO8)	
7	D	drain		
8	D	drain		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PHK5NQ15T	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	150	V
V_{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	150	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	T_{sp} = 100 °C; V_{GS} = 10 V; see <u>Figure 1</u>	-	3.23	Α
		T_{sp} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> and <u>3</u>	-	5	Α
I _{DM}	peak drain current	T_{sp} = 25 °C; $t_p \le 10 \mu s$; pulsed; see Figure 3	-	20	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 2</u>	-	6.25	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dr	ain diode				
Is	source current	T _{sp} = 25 °C	-	5	Α
I _{SM}	peak source current	T_{sp} = 25 °C; $t_p \le 10 \mu s$; pulsed	-	20	Α

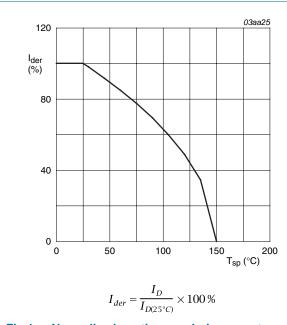


Fig 1. Normalized continuous drain current as a function of solder point temperature

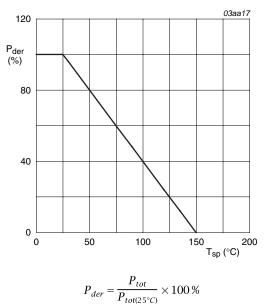


Fig 2. Normalized total power dissipation as a function of solder point temperature

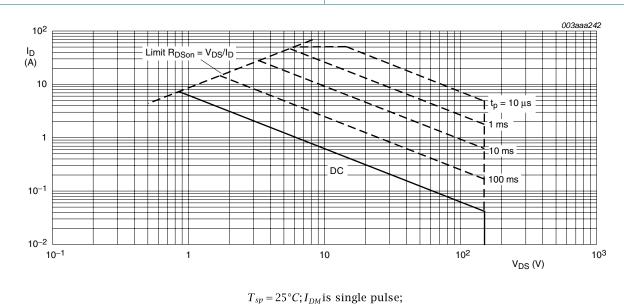


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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Thermal characteristics

Table 5. **Thermal characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-	-	20	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint; mounted on printed-circuit board	-	70	-	K/W

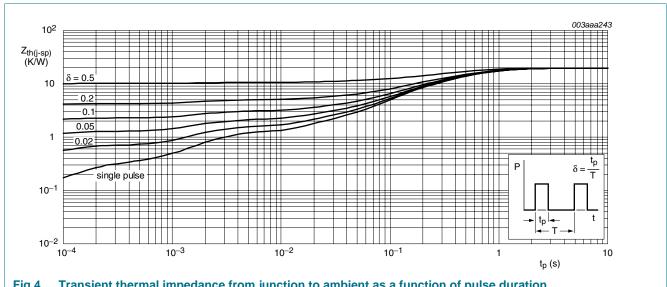


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration

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6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	134	-	-	V
	voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	150	-	-	V
$V_{GS(th)}$	gate-source threshold	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see <u>Figure 8</u>	-	-	4.5	V
	voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 150 \text{ °C}$; see Figure 8	1.2	-	-	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see Figure 8	2	3	4	V
I_{DSS}	drain leakage current	$V_{DS} = 120 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 120 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	100	μΑ
I_{GSS}	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 5 A; T_j = 150 °C; see <u>Figure 9</u> and <u>10</u>	-	129	173	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 3 \text{ A}; T_j = 25 \text{ °C}$	-	60	80	mΩ
		V_{GS} = 10 V; I_D = 5 A; T_j = 25 °C; see <u>Figure 9</u> and <u>10</u>	-	56	75	mΩ
Dynamic	characteristics					
$Q_{G(tot)}$	total gate charge	$I_D = 5 \text{ A}$; $V_{DS} = 75 \text{ V}$; $V_{GS} = 10 \text{ V}$; $T_j = 25 \text{ °C}$;	-	29	-	nC
Q_{GS}	gate-source charge	see <u>Figure 11</u>	-	3	-	nC
Q_{GD}	gate-drain charge		-	12	-	nC
C _{iss}	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25 °C;$	-	1150	-	pF
C_{oss}	output capacitance	see <u>Figure 12</u>	-	187	-	pF
C _{rss}	reverse transfer capacitance		-	61	-	pF
d(on)	turn-on delay time	$V_{DS} = 75 \text{ V}; R_L = 15 \Omega; V_{GS} = 10 \text{ V};$	-	12	-	ns
r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 \text{ °C}; I_D = 5 A$	-	12	-	ns
d(off)	turn-off delay time		-	35	-	ns
f	fall time		-	18	-	ns
Source-di	rain diode					
√ _{SD}	source-drain voltage	$I_S = 5 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see <u>Figure 13</u>	-	0.8	1.2	V
t _{rr}	reverse recovery time	$I_S = 5 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$;	-	87	-	ns
Q _r	recovered charge	$V_{DS} = 90 \text{ V; } T_j = 25 \text{ °C}$	-	162	-	nC

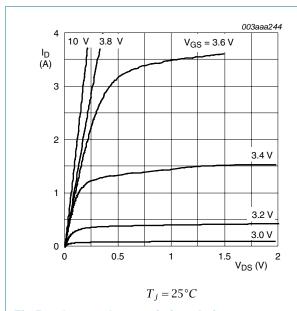


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

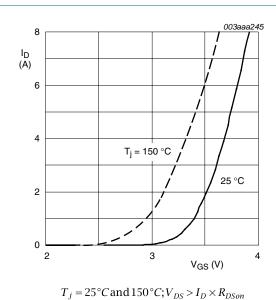


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

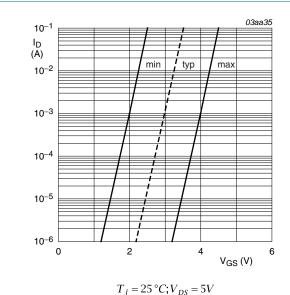


Fig 7. Sub-threshold drain current as a function of gate-source voltage

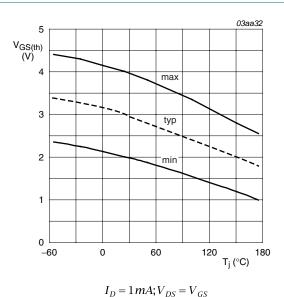


Fig 8. Gate-source threshold voltage as a function of junction temperature

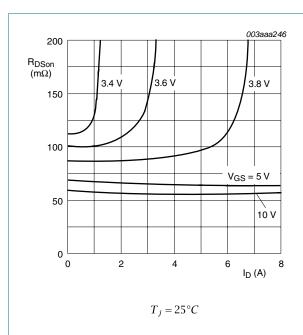


Fig 9. Drain-source on-state resistance as a function of drain current; typical values

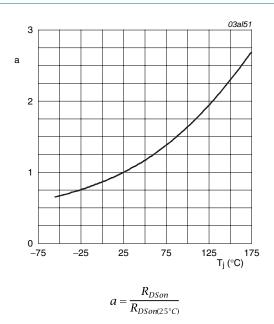


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature

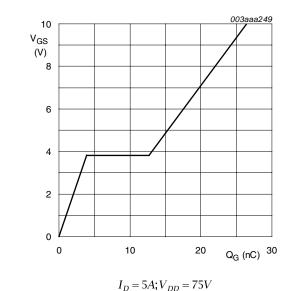


Fig 11. Gate-source voltage as a function of gate charge; typical values

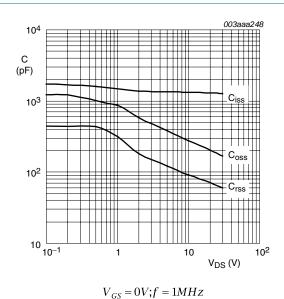
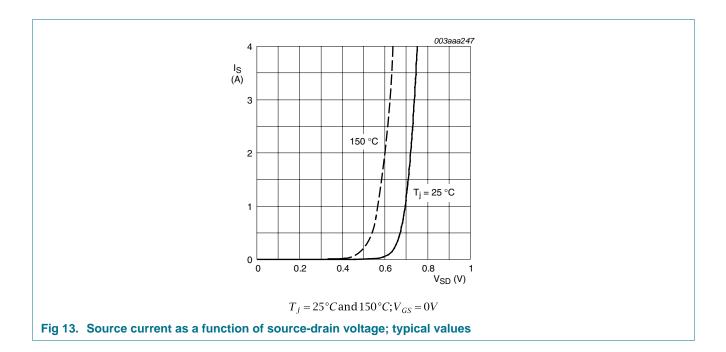


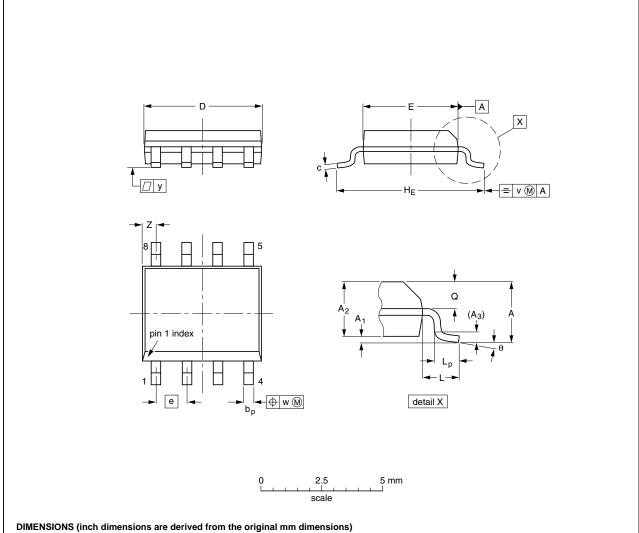
Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	Ф	HE	L	Lp	ď	>	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01	1	0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

	OUTLINE		REFER	EUROPEAN	ISSUE DATE		
	VERSION	IEC	JEDEC	JEITA		PROJECTION	1330E DATE
	SOT96-1	076E03	MS-012				99-12-27 03-02-18
_							

Fig 14. Package outline SOT96-1 (SO8)

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
PHK5NQ15T_2	20100304	Product data sheet	-	PHK5NQ15T-01				
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 							
 Legal texts have been adapted to the new company name where appropriate 								
PHK5NQ15T-01	20030120	Product data	-	-				

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9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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